SPAR - BRAMPTON (SSS) 9445 AIRPORT RD

Critical Items List

SRMS

CIL Ref#: 3076

Revision: 0

FMEA Rev: 0

BRAMPTON ONTARIO L654J3

System: SRMS

Subsystem: ELECTRICAL SUB-SYSTEM

Assembly Desc: Servo Power Amplifier

Part Number(s): 5!140F1177-3

51140F1177-5

Item:

Function: Motor Orive Amplifier Assembly

Provides motor voltage based on damand from tachometer electronics. Commutates the motor drive voltage. Provides hardware current limiting, brake drive, direct drive functions and enables backup drive. Provides BITE directly and

BITE verification for MDA.

Failure Mode: Loss of or corrupt commutation.

HW Func. Screen Failures

Criticality:

Mission Phase: Orbit

Cause(s): Motor Drive Amplifier Assembly

Commutation pattern generator logic feiled.

Commutator direction flag TE\_DIR1 fails high or low.

Erroneous commutation direction.

Excessive voltage applied to commutation bridge. Loss of MDA enable in computer supported modes.

Loss of MDA enable in Direct Drive, Loss of one of +12VDC bridge supplies. Loss of or erroneous commutator data. Loss of voltage at the motor terminals. One bridge switch feils open or closed.

Failure effect on unit/end item:

> Degraded or loss of motor torque in computer supported and direct drive modes. Computer supported modes are lost. Direct Drive mode may be lost. Commutator BITE will detect if commutator data is corrupt. MDA demand voltage switch BITE will detect if commutation of motor is not consistent with commutator data. When brakes are ON, motor drive fault detection may detect.

Worst Case: Unexpected motion. Sluggeth joint, Autobrakes.

Redundant Paths: Autobrakes (to Safe the System).

Direct Orive (If Available).

Backup Drive.

#### etention Rationale

### Design:

The design utilizes proven circuit techniques and is implemented using CMOS logic devices. CMOS devices operate at low power and hence do not experience significant operating stresses. The technology is mature, and device reliability history is well documented. All stresses are additionally reduced by denting the appropriate parameters in accordance with SPAR-RMS-PA.003. Special handling precautions are used at all stages of manufacture to preclude demage/stress due to electrostatic discharge.

Comparators and operational amplifiers are standard linear integrated circuits with mature manufacturing technology. Application constraints are in accordance with SPAR-RMS-PA.003.

18Sep96 by Fung, Bill epared:

RMS/ELEC - 745

Supersedes: N/A

## SPAR - BRAMPTON (SSS) 9445 AIRPORT RD

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SRA

BRAMPTON ONTARIO L654J3

CIL Ref#: 3076

Revision: 0

FMEA Rev: 0

Discrete semiconductor devices are specified to at least the TX level of Mit.-S-19500. Samples of all procured lots/data codes are subto destructive physical analysis (DPA) to verify the integrity of the manufacturing processes. Perticle Impact Noise Detection (PIND) screenis performed on microcircuits, transistor and clodes that are mounted in a package with an internal cavity construction. The purpose of the lesto detect losse particles in the package, usually resulting from the assembly process. Device stress levels are derated in accordance with SPAR-RMS-PA.003 and verified by design review.

Field Programmable Gate Arrays (FPGA's) and the Error Defection and Correction (EDAC) are semi-custom microcircuits in which the bas design functional elements are designed by the manufacturer. The interconnection of these elements is then customized by Spar to provide the functionality of the completed microcircuit. The design utilizes proven circuit techniques and is implemented using CMOS technology. This technology operates at low power and hence the device does not experience significant operating stresses. The technology is mature, and the basic device reliability is well documented. All stresses are additionally reduced by dereting the appropriate parameters in accordance with SPAR-RMS-PA.003 and verified by design review.

This approach has a significant advantage in that it reduces the quantity of discrete parts required in the assembly and also the complexity the PWB and results in significant weight and volume savings. This type of semi-custom part has been successfully used in other space applications.

The parts are qualified to the requirements of the applicable specification. They are 100% acreened and burned in to the requirements of the Spar requirements document.

Resistors and capacitors used in the design are selected from established reliability (ER) types. Life expectancy is increased by ensuring that all allowable stress levels are derated in accordance with SPAR-RMS-PA.003. All ceramic and electrolytic capacitors are routinety subjected to radiographic inspection in accordance with the requirements of MSFC-STD-355.

Transformers and inductors are designed specifically for the application. These are toroid-wound and utilize a famile core material. Choice of wire size and of insulation materials ensure that the derating requirements of SPAR-RMS-PA.003 are met.

The SPA board is fabricated using Surface Mount Technology (\$MT). This is a PWB assembly technology in which the components are soldered to the solder pads on the surface of the PWB. The significant advantage of this technology is to enable the parts on the board to be more densely packed, to reduce to overall volume and weight of the assembly.

The assembly process is highly automated. The parts are mounted on the boards using a computer controlled "pick and place" mechine. The subsequent soldering operation is performed using a belt furnace, in which the time and temperature thermal profile that the PWB assembly is exposed to is tightly controlled and optimized to ensure proper part soldering attachment. The assembly is manufactured under documented procedures and quality controls. These controls are exercised throughout the assembly, inspection, and testing of the unit. This inspection includes workmanship, component mounting, soldering, and conformal coeffing to ensure that it is in accordance with the NMB 5300 standards.

The SMT line used for the SPA PWB assembly has undargone a full qualification program, and assemblies produced on this line are use other space programs.

The circuit board design has been reviewed to ensure adequate conductor width and separation and to confirm appropriate dimensions of solder pads and of component hold provisions. Parts mounting methods are controlled in accordance with MSFC-STD-154A, MSFC-STD-138 and SASD 2573751. These documents require approved mounting methods, stress raisef and component sequirity.

Field Effect Transistors (FETs) IRFM054 (Q6 through Q11) are procured and screened in accordance with source control document EVPF27-102-M101. This procurement procedure ensures that these FETs have a minimum gets source voltage of 2.69V.

### Test:

188ep96 by Fung, Bill

Prepared:

QUALIFICATION TESTS - The SPA is subjected to the following qualification testing:

VIBRATION. Each axes of the QM is subjected to Flight Acceptance Vibration Test (FAVT), Qualification Acceptance Vibration Test (QAVT), and Qualification Vibration Tests (QVT) in accordance with the SPA Vibration Test Procedure (926568). The level and duration for FAVT is as per Figure 6 and Table 2 of 826566; the level and duration for QAVT is as per Figure 8 and Table 3 of 826565. At the end of the three successive random vibration test in each axis, both directions (+/-) of each of the axis is subjected to a shock pulse test as per Figure 9 of 826586.

THERMAL/VACUUM: QM TVAC Test is in accordance with Figure 5 of the SPA TVAC Test Procedure (826568), with full Functional/Parametric Test performed at levels of +50 degrees C and -35 degrees C, and non-operating at -54 degrees C. The Qualification vacuum levels during TVAC is 1X10\*\*-8 torr or less. The total test duration is ? 1/2 cycles. The QM SPA is subjected to a minimum of 1000 hours of life testing and 1000 power On-Off cycles.

EMC: The QM is subjected to EMC Testing (tests CE01/CE03, CE07, CS01, CS02, CS08, RE02, R502, and R503) in accordance with the SPA EMC test Procedure (826477) based on MIL-8TD-481A.

UNIT FLIGHT ACCEPTANCE TESTS - The FM SPA is subjected to the following acceptance testing:

VIBRATION: FM Acceptance Vibration Test (AVT) in accordance with the SPA Vibration Test Procedure (826586), with level and duration as per Figure 6 and Table 2 of 826588.

THERMAL/VACUUM: FM TVAC Test is in accordance with Figure 6 of the SPA TVAC Test Procedure (826588), with levels of +49 degrees 0 and -25 degrees 0 for a duration of 1 1/2 cycles. The vacuum levels during Acceptance TVAC Test is 1X10\*\*-5 for or less.

JOINT SRU TESTS - The SPA is tested as part of the joints (ambient and vibration tests only). The embient ATP for the Shoulder Joint, Elbow Joint, and Wrist Joint are as per ATP.2001, ATP.2003, and ATP.2006 respectively. The vibration test for the Shoulder Joint, and Elbow or Wrist Joint are as per ATP.2002, ATP.2004 and ATP.2006 respectively. Through wire function, continuity and electingal isolation tests of performed per TP.263.

Supersedes; N/A

# SPAR - BRAMPTON (888)

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FMEA Rev: 0

RAMPTON ONTARIO L6843

MECHANICAL ARM REASSEMBLY - The SPA's/Joints undergo a mechanical arm integration stage where electrical chacks are performed

MECHANICAL ARM TESTING - The outgoing split-arm is configured on the Strongback and the Manipulator Arm Chickout is performed per ATP 1932.

FLIGHT CHECKOUT: PDRS OPS Checkout (all vehicles) JSC 18987.

#### Inspection;

Units are manufactured under documented quality controls. These controls are exercised throughout design procurement, planning, receiving, processing, fabrication, assembly, testing and shipping of the units. Mandatory inspection points are employed at various stages of fabrication, assembly, and test. Government source inspection is invoked at various control levels.

EEE parts inspection is performed as required by SPAR-RMS-PA.003. Each EEE part is qualified at the part level to the requirements of the applicable specification. All EEE parts are 100% screened and burned-in, as a minimum, as required by SPAR-RMS-PA.003, by the supplier. DPA is performed as required by PA.003 on a randomly selected 5% of parts, maximum 5 pieces, minimum 3 pieces for each lot number/date code of parts received. All cavity devices are subjected to 100% PIND. Wire is procured to specification MIL-W-22759 or MIL-W-81381 and imprected and tested to NASA JSCM8060 Standard Number 95A.

Receiving Inspection verifies that all parts received are as identified in the procurement documents, that no physical demage has occurred to parts during shipment, that the receiving documents provide adequate traceability information and screening data clearly identifies acceptable parts

Parts are inspected throughout manufacture and assembly as appropriate to the manufacturing stage completed. These inspections include: Printed circuit board inspection for track separation, damage and adequacy of plated through holes, component mounting inspection for correct soldering, ware looping, strapping, etc. Operators and inspectors are trained and certified to NASA NHB 5300.4(3A-1) Standard. Conformal coating inspection for adequate processing is performed using ultraviolet light techniques. P.C. Board installation inspection includes checks for correct board installation, alignment of boards, proper connector contact mating, wire routing, strapping of wires etc. Post P.C. Board installation inspection includes cleanliness and workmanship (Spar/government rep. mandatory inspection point),

Unit Pre-Acceptance Test inspection, which includes an audit of lower tier inspection completion, as built configuration verification to as design etc (mandatory inspection point). A unit Test Readiness Review (TRR) which includes verification of test personnel, test documents, test equipment calibration/validation status and haroware configuration is convened by QA in conjunction with Engineering, Reliability, Configuration Control, Supplier as applicable, and the government representative, prior to the start of any formal testing (Acceptance or Qualification). Unit level Acceptance Testing (ATP) includes ambient performance, thermal and vibration testing (Spar/government rep. mandatory inspection point).

Integration of unit to Joint SRU - Inspections include grounding checks, connectors for bent or pushback contacts, visual, cleanliness, interconnect wiring and power up test to the appropriate Joint Inspection Test Procedure (ITP). Joint level Pre-Acceptance Test Inspection, includes an audit of lower tier inspection completion, as built configuration verification to as design etc. Joint level Acceptance Testing (ATP) includes ambient and vibration testing (Spar/government rep. mandatory inspection point).

Mechanical Arm Reassembly - the integration of mechanical arm subassemblies to form the assembled arm. Inspections are performed at each phase of integration which includes electrical checks, through wiring checks, wiring routing, interface connectors for bent or pushback contacts etc. Mechanical Arm Testing - Strongback and flat floor ambient performance test (Sper/government rep. mandatory inspection point).

OMRSD Offline: Power-up arm. Check availability of Computer Supported modes. Select Direct Drive and with Brakes OFF verify no ABE communication. failures or BITE errors.

OMRSD Online None.

Installation:

OMRSD Online Power-up arm. Check availability of Computer Supported modes. Select Direct Drive and with Brakes OFF verify no ABE communication. Turnaround: failures or BITE errors.

Screen Fadure: A; Pass

8: Pass

C: Pass

Craw Training: The craw will be trained to always observe whether the arm is responding properly to commands. If it exit, apply brakes,

iperational Effect: Cannot use Computer Supported modes. Direct Drive may not be available. Autobrakes. Back-up is available. Arm will not stop automatically if

Crew Action: Select Direct Drive if available. If D/D not available select Back-up Drive, Single/Direct Drive switch should be pulsed to maintain proper rates.

failure of the autobrake system has previously occurred. Brakes can be applied manually.

Mission. Operate under vernier rates within approximately 10 ft of structure. The operator must be able to detect that the arm is responding properly to Constraints: commands via window and/or CCTV views during all arm operations. Auto trajectories must be designed to come no closer than approximately 5 ft from structure.

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BRAMPTON ONTARIO L6\$4J3

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FMEA Rev: 0

SRN

Functional Group	Name	Position	Telephone	Oute Signed	20.00
Engi <b>nee</b> r	Hiltz, Michael / SPAR-BRAMPTON	Systems Engineer			Status
Reliability	Molgaard, Lens / SPAR-BRAMPTON		4634	06Mar98	5igne
•		Reliability Engineer	4590	06Mar98	Signe
	Rice, Craig / SPAR-BRAMPTON	Technical Program Manager	4692	C6Mar98	Signe
Subsystem Manager	Glehn, George / JSC-ER	RMS Subsystem Manager	(261) 483-1516	30Mar98	_
Technical Manager	Allison, Ron / JSC-MV6	RMS Project Engineer JSC	, ,	4	Signe
		TOPIC CIGINAL USC	(713) 483-4072	09Apr98	Signe

SAFETY - MISHON ASSURANCE CHAM, DAVID ISSUNCE RAS SOMA ENGINER (20) 483-5499 JOHNST MINIC.